

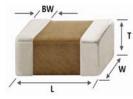
# Specification of Automotive MLCC (Reference sheet)



- Supplier : Samsung Electro-Mechanics
- Product : Multi-layer Ceramic Capacitor
- Samsung P/N : CL21B224KBFVPNE
- Description : CAP, 220 nF, 50V, ± 10%, X7R, 0805
- AEC-Q200 Qualified

## A. Dimension





Size	0805 inch			
L	2.00±0.10 mm			
W	1.25±0.10 mm			
Т	1.25±0.10 mm			
BW	0.50+0.20/-0.30 mm			

#### B. Samsung Part Number

<u>CL</u>	<u>21</u>	<u>B</u>	<u>224</u>	<u>ĸ</u>	B	E	<u>v</u>	<u>P</u>	<u>N</u>	E
1	2	3	4	5	6	$\bigcirc$	8	9	10	1

① Series Samsung Multi-layer Ceramic Capacitor			
② Size	0805 (inch code)	L: 2.00±0.10 mm	W :1.25±0.10 mm
③ Dielectric	X7R	Inner electrode	Ni
④ Capacitance	220 nF	Termination	Metal-Epoxy
5 Capacitance	± 10%	Plating	Sn 100% (Pb Free)
tolerance		9 Product	Automotive
⑥ Rated Voltage	50 V	Special code	Normal
⑦ Thickness	1.25±0.10 mm	① Packaging	Embossed Type, 7" Reel

#### C. Reliability Test and Judgement condition

Test items	Performance	Test condition		
ligh Temperature Appearance : No abnormal exterior appearance		Unpowered, 1,000hrs @ Max. temperature		
Exposure	Capacitance Change Within ±10 %	Measurement at 24±2hrs after test conclusion		
	Tan δ :0.03 max.			
	IR :More than 10,000 <sup>M</sup> Ω or 500 <sup>M</sup> Ω× <i>μ</i> F	Initial Measurement 2*		
	Whichever is smaller	Final Measurement 3*		
Temperature Cycling	Appearance : No abnormal exterior appearance	1,000Cycles		
	Capacitance Change Within ±10 %	Initial Measurement 2*		
	Tan δ :0.03 max.	Final Measurement 3*		
	IR : More than 10,000 M $_{\Omega}$ or 500 M $_{\Omega} \times \mu$ F	Measurement at 24±2hrs after test conclusion		
	Whichever is smaller	1 cycle condition : -55+0/-3 °C (30±3min) → Room Temp. (1min)		
		→ 125+3/-0 $^{\circ}$ C (30±3min) → Room Temp. (1min)		
Destructive Physical	No Defects or abnormalities	Per EIA 469		
Analysis				
Humidity Bias	Appearance : No abnormal exterior appearance	1,000hrs 85 °C/85%RH, Rated Voltage and 1.3~1.5V,		
	Capacitance Change Within ±12.5 %	Add 100kohm resistor		
	Tan δ :0.035 max.	Initial Measurement 2*		
	IR :More than 500 <sup>M</sup> Ω or 25 <sup>M</sup> Ω× <i>μ</i> F	Final Measurement 4*		
	Whichever is smaller	Measurement at 24±2hrs after test conclusion		
		The charge/discharge current is less than 50mA.		
High Temperature	Appearance : No abnormal exterior appearance	1,000hrs @ 125℃, 200% Rated Voltage,		
Operating Life	Capacitance Change Within ±12.5 %	Initial Measurement 2*		
	Tan δ :0.035 max.	Final Measurement 4*		
	IR :More than 1,000 <sup>M</sup> ♀ or 50 <sup>M</sup> ♀× <i>µ</i> F	Measurement at 24±2hrs after test conclusion		

	Performance	Test condition				
External Visual	No abnormal exterior appearance	Microscope ('10)				
Physical Dimension	Within the specified dimensions	Using The calipers				
Mechanical Shock	Appearance : No abnormal exterior appearance	Three shocks in each direction should be applied along				
	Capacitance Change Within ±10 %	3 mutually perpendicular axes of the test specimen (18 shocks)				
	Tan δ, IR : Initial spec.	Peak value Duration Wave Velocity				
		1,500G 0.5ms Half sine 4.7m/sec				
		Initial Measurement 2*				
		Final Measurement 5*				
Vibration	Appearance : No abnormal exterior appearance	5g's for 20min., 12cycles each of 3 orientations,				
	Capacitance Change Within ±10 %	Use 8"×5" PCB 0.031" Thick 7 secure points on one long side				
	Tan δ, IR : Initial spec.	and 2 secure points at corners of opposite sides. Parts mounted				
		within 2" from any secure point. Test from $10~2,000$ Hz.				
		Initial Measurement 2*				
		Final Measurement 5*				
Resistance to	Appearance : No abnormal exterior appearance	preheating : 150℃ for 60~120 sec.				
Solder Heat	Capacitance Change Within ±10 %	Solder pot : 260±5℃, 10±1sec.				
	Tan δ, IR : Initial spec.	Initial Measurement 2*				
		Final Measurement 3*				
ESD	Appearance : No abnormal exterior appearance	AEC-Q200-002 or ISO/DIS10605				
	Capacitance Change Within ±10 %	Initial Measurement 2*				
	Tan δ, IR : Initial spec.	Final Measurement 4*				
Solderability	95% of the terminations is to be soldered	a) Preheat at 155 $^\circ C$ for 4 hours, Immerse in solder for 5s at 245±5 $^\circ C$				
	evenly and continuously	b) Steam aging for 8 hours, Immerse in solder for 5s at $245\pm5$ °C				
		c) Steam aging for 8 hours, Immerse in solder for 120s at 260±5				
		solder : a solution ethanol and rosin				
Electrical	Capacitance : Within specified tolerance	*A capacitor prior to measuring the capacitance is heat treated at				
Characterization	Tan δ :0.025 max.	150 +0/-10°C for 1hour and maintained in ambient air for 24±2 hours The Capacitance / D.E. should be measured at 25°C				
	IR(25℃): More than 10,000 <sup>M</sup> Ω or 500 <sup>M</sup> Ω×μ <sup>F</sup>	The Capacitance / D.F. should be measured at $25^{\circ}$ C,				
	Whichever is smaller	$1 \text{ kHz} \pm 10\%$ , $1 \pm 0.2 \text{ Vrms}$				
	IR(125°C) More than 1,000 M <sup><math>\Omega</math></sup> or 10 M <sup><math>\Omega</math></sup> × $\mu$ F	I.R. should be measured with a DC voltage not exceeding				
	Whichever is smaller	Rated Voltage @25°C, @125°C for 60~120 sec.				
	Dielectric Strength	Dielectric Strength : 250% of the rated voltage for 1~5 seconds				
Deerd Flow	Appearance : No abnormal exterior appearance	Bending to the limit, 3 mm for 60 seconds 1*				
Board Flex	Capacitance Change Within ±10 %	Initial Measurement 2*				
	Capacitance Change Within 110 /	Final Measurement 5*				
Terminal	Appearance : No abnormal exterior appearance	18 N, for 60 sec.				
Strength(SMD)	Capacitance Change Within ±10 %	Initial Measurement 2*				
Strength(SWD)		Final Measurement 5*				
Beam Load	Destruction value should be exceed 20 N	Beam speed : 0.5±0.05 mm/sec				
Temperature	X7R					
Characteristics	From -55 $\degree$ to 125 $\degree$ , Capacitance change shou	ld be within ±15%				

D. Recommended Soldering method :

Reflow ( Reflow Peak Temperature : 260 +0/-5 °C, 30sec. ), Meet IPC/JEDEC J-STD-020 D Standard

- \*1 : The figure indicates typical specification. Please refer to individual specifications.
- \*2 : Initial measurement : Perform a heat treatment at 150 +0/-10 °C for one hour after soldering process. and then let sit for 24±2 hours at room temperature. Perform the initial measurement.
- $^{*3}$  : Final measurement : Let sit for 24±2 hours at room temperature after test conclusion, then measure.
- \*4 : Final measurement : Perform a heat treatment at 150 +0/-10 °C for one hour after soldering process. and then let sit for 24±2 hours at room temperature. Perform the initial measurement.
- \*5 : Final measurement : Let measure within 24 hours at room temperature after test conclusion.

A Product specifications included in the specifications are effective as of March 1, 2013.

Please be advised that they are standard product specifications for reference only.

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- Aerospace/Aviation equipment
- ② Medical equipment
- *③ Military equipment*
- ④ Disaster prevention/crime prevention equipment
- *5* Power plant control equipment
- 6 Atomic energy-related equipment
- ⑦ Undersea equipment
- ⑧ Traffic signal equipment
- Data-processing equipment
- 10 Electric heating apparatus, burning equipment
- ${\it I\!\! D}$  Safety equipment
- 2 Any other applications with the same as or similar complexity or reliability to the applications